

Electronic excitations and metal-insulator transition in poly(3-hexylthiophene) organic field-effect transistors

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We carry out a comprehensive theoretical and experimental study of charge injection in poly(3-hexylthiophene) (P3HT) to determine the most likely scenario for metal-insulator transition in this system. We calculate the optical-absorption frequencies corresponding to a polaron and a bipolaron lattice in P3HT. We also analyze the electronic excitations for three possible scenarios under which a first- or a second-order metal-insulator transition can occur in doped P3HT. These theoretical scenarios are compared with data from infrared absorption spectroscopy on P3HT thin-film field-effect transistors (FETs). Our measurements and theoretical predictions suggest that charge-induced localized states in P3HT FETs are bipolarons and that the highest doping level achieved in our experiments approaches that required for a first-order metal-insulator transition.

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I. INTRODUCTION

Upon doping the conductivity of conjugated organic polymers can be controlled over an extraordinarily large range from insulator to metal.¹ Therefore these materials hold great promise for high-performance organic electronics.²⁻⁴ The organic field-effect transistor is a benchmark system for exploring the fundamental properties of the organic semiconductors as well as for exploiting their novel functionalities.^{5,6} Recently, particular interest has been devoted to field-effect transistors (FETs) based on highly regio-regular (RR) poly(3-hexylthiophene) (P3HT) (see Fig. 1).⁷⁻¹⁷ The charge-carrier mobility in these devices has been found as high as 0.7 cm²/V s, enhanced by orders of magnitude compared to that of the more disordered P3HT films. There has also been a strong interest in using the voltage in the organic FETs to induce a sufficiently high density of carriers so that metallic states can be produced in the polymers.^{16,17}

Unlike traditional semiconductors, charge injection into organic polymers induces structural deformations in the polymer chains and gives rise to self-localized excitation states inside the band gap. The Peierls instability in *trans*-polyacetylene (PA) leads to solitons,¹⁸ or kinklike excitations with a twofold-degenerate ground state. However, most of the conjugated polymers are analogous to *cis*-PA, which consists of two nondegenerate ground states (NDGS); i.e., the two conformations resulting from the mutation of a single and a double C-C bond are not energetically equivalent. Two possible excitations in NDGS conjugated polymers are polarons or bipolarons that are associated to a pair of bound states in the band gap split off from the continuum.¹⁸ Experimental evidence of similar signatures have been reported in P3HT and have been interpreted in terms of both types of excitations. Earlier work on chemical doping and photoinduced absorption in P3HT have assigned the two localized intragap states observed to bipolarons,¹⁹ whereas a more recent study of RR-poly(3-alkylthiophene) concluded that while chemical doping in P3HT films results in localized polarons, photoexcitations give rise to delocalized

polarons.¹⁰ A charge modulation spectroscopy experiment in regio-random P3HT in a metal-insulator-semiconductor diode has identified five subgap transition features, out of which two are associated to optical transitions of doubly charged bipolarons and three to singly-charged polarons, suggesting coexistence of the two charge species.²⁰ More recently, however, the same technique applied to RR P3HT identified only three subgap features, which were assigned to polarons.^{9,21}

Metallic states attested by a finite density of states at the Fermi energy have been reported in chemically doped P3HT polymers using photoemission spectroscopy and have been attributed to the polaron lattice.²² On the other hand, there exists a model which supports the bipolaron lattice in NDGS polymers, arguing that the metallic states are a consequence of the merging of the bipolaron band with either the valence or the conduction band.²³ However, in neither of these studies has a prediction of the critical doping concentration under which P3HT becomes metallic been given.

Here we report a joint theoretical and experimental study of charge-induced electronic excitations in P3HT. We present models for three scenarios under which charge-induced transitions between the bipolaron lattice and the polaron lattice or the merging between the localized states and the extended states can take place. We predict the critical

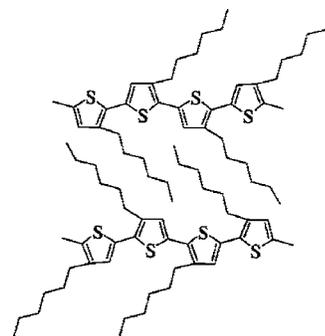


FIG. 1. Schematic diagram of RR P3HT.

doping thresholds above which metallic states can be expected in charge-injected P3HT. To this end, we apply the continuum Hamiltonian model introduced by Brazovskii and Kirova²⁴ (BK) for *cis*-PA that takes into account the electronic and lattice couplings. We carried out infrared spectroscopic studies in P3HT-based FETs. From these measurements we extract the charge-injected doping levels and compare with the predicted critical values, which provide a lower bound for metallic behavior. The analysis suggests that the charge carriers in our P3HT FET are bipolarons and the highest charge injection level reaches the proximity of the critical doping value that is needed for metallic states in P3HT. We also discuss our results in view of very recent experimental evidence of field-induced metallic behavior in P3HT FETs,¹⁶ and a structurally similar polymer with polyelectrolyte gate dielectric.²⁵

The paper is organized as follows. In Sec. II, we briefly review the solution of the BK model as derived in the literature and provide an analytical formulation for bandwidths of polarons and bipolarons. In Sec. III, the solutions are applied to three scenarios involving polaron and bipolaron states in P3HT. From this study the critical dopings required to achieve metallic states in P3HT are predicted. In Sec. IV, we present experimental results on charge injection in P3HT-based transistors and we compare them with the theoretical predictions in Sec. V.

II. THEORETICAL FORMULATION

A. Polarons and bipolarons

The Su-Schrieffer-Heeger (SSH) (Ref. 26) electron-phonon coupling model and its continuum version²⁷ have been widely used to study structural excitations (solitons, polarons) in degenerate polymers such as *trans*-PA. In NDGS polymers, however, the degeneracy is broken. A generalization of the SSH model by Brazovskii and Kirova has been proposed to take into account the one-electron energy gap in the absence of dimerization. The solution of this model has been derived and discussed elsewhere;^{24,28,29} here we briefly summarize the main results.

The gap parameter contains both an intrinsic and an extrinsic contribution $\Delta(x) = \Delta_e + \Delta_i(x)$, where $\Delta_i(x)$ is associated with the dimerization due to the π -electron-lattice interaction and Δ_e is a constant gap parameter that arises from the σ -bond orbitals. The BK continuum Hamiltonian is written as

$$H = \int dx \frac{\Delta_i(x)^2}{\pi \lambda v_F} + \int dx \Psi^\dagger(x) \left[-i v_F \sigma_3 \frac{\partial}{\partial x} + \Delta(x) \sigma_1 \right] \Psi(x). \quad (1)$$

Here, the first term describes the interaction of the electrons with the lattice deformation $\Delta_i(x)$, $\Psi(x)$ is the two-component fermion field, λ is the dimensionless electron-phonon coupling strength, and v_F is the Fermi velocity of the π electrons. The second term describes the self-energy of the π electrons in a field of a dimerization potential $\Delta(x)$, while σ_i are the Pauli matrices.

In the continuum limit, the analytical solution of the BK Hamiltonian represents a polaron or a bipolaron,

$$\Delta(x) = \Delta_0 + k v_F \{ \tanh[k(x - x_0)] - \tanh[k(x + x_0)] \}, \quad (2)$$

with

$$\tanh(2kx_0) = \frac{k v_F}{\Delta_0} \quad (3)$$

and

$$\Delta_0 = W e^{-1/\lambda} e^\gamma, \quad (4)$$

where W is the width of the π -band and $\gamma = \frac{\Delta_e}{\lambda \Delta_0}$ is the confinement parameter that describes the extent of the energy degeneracy breaking.

There are two bound states corresponding to the polaron solution in Eq. (2) with eigenvalues symmetrically placed in the gap at $\pm \omega_0$ where

$$\omega_0 = \Delta_0 \sqrt{1 - (k \xi_0)^2} \quad (5)$$

and $\xi_0 = \frac{v_F}{\Delta_0}$ is the parameter that describes the spatial extent of the soliton kink. Minimizing the energy of Eq. (1) with respect to ω_0 yields the following self-consistent condition for k :

$$\frac{k v_F}{\omega_0} \gamma = \sin^{-1} \left(\frac{\omega_0}{\Delta_0} \right) + \frac{\pi}{4} (n_+ - n_-), \quad (6)$$

where n_\pm are the occupation numbers of the discrete energy levels. For a singly charged system such as an electron polaron or a hole polaron, $n_+ - n_- = -1$, and for a doubly charged system such as a bipolaron, $n_+ - n_- = 0$. The polaron (bipolaron) formation energy can be obtained from the total energy given in the above configuration,²⁹

$$E_{p,b} = \frac{4}{\pi} \left[(1 - \gamma) k v_F + 2 \gamma \Delta_0 k x_0 + \omega_0 \sin^{-1} \left(\frac{\omega_0}{\Delta_0} \right) \right] + (n_+ - n_-) \omega_0. \quad (7)$$

B. Bandwidth of polarons and bipolarons

As the doping level increases, the charges stored on individual polaron states overlap and give rise to the polaron band. The bandwidth can be calculated from the off-diagonal element of the BK Hamiltonian between unperturbed states on each polaron.³⁰ Here we follow the approach of Onodera²⁹ in which the interaction between two hole-doped polarons approaching each other are considered. When the doping level increases, the overlap of electron wave functions trapped in the two polaron dips in $\Delta(x)$ gets stronger and the two bound-state energy levels $\pm \omega_0$ are each split into two levels $\pm \omega_1$ and $\pm \omega_2$ (bonding and antibonding states). The system can lower its energy by accommodating both holes on the lowest level.

In a tight-binding approximation, the bandwidth of the polarons can then be calculated from the difference between the two discrete levels. The gap parameter for the two polaron or two bipolarons is found to be²⁹

$$\Delta(x) = \Delta_0 + \frac{(k_1^2 - k_2^2)v_F}{k_1 \coth(k_1x - \beta_1) - k_2 \tanh(k_2x - \beta_2)} - \frac{(k_1^2 - k_2^2)v_F}{k_1 \coth(k_1x + \beta) - k_2 \tanh(k_2x + \beta_2)}, \quad (8)$$

where

$$\tanh 2\beta_j = k_j \xi_0 \quad (j = 1, 2), \quad (9)$$

and k_1 and k_2 are related to the discrete energy levels by

$$\omega_j = \Delta_0 \sqrt{1 - (k_j \xi_0)^2}. \quad (10)$$

As the two polarons approach each other, $k_1 - k_2$ becomes nonzero and is asymptotically related to the separation d between the two polarons via

$$k_1 - k_2 = 4ke^{-dk} \quad (11)$$

at large distances. Therefore the separation between the bonding and antibonding states can be calculated from Eq. (10) which now becomes

$$(k_1^2 - k_2^2)v_F^2 + (\omega_1^2 - \omega_2^2) = 0. \quad (12)$$

If the separation d is large, $k_1 - k_2$ is small, we can rewrite this relation as

$$k(k_1 - k_2)v_F^2 + \omega_0(\omega_1 - \omega_2) = 0. \quad (13)$$

Replacing d by the dopant concentration $y = a/d$, where a is the projected bond length along the chain axis, we obtain the bandwidth of the polarons

$$W_p(y) = -4(\omega_0 - \omega_2) \approx 8 \frac{k^2 v_F^2}{\omega_0} e^{-kaly}. \quad (14)$$

In a similar fashion, the two-bipolaron system has been solved,²⁹ and an asymptotic expression of the bipolaron bandwidth similar to that for the polarons can be obtained,

$$W_b(y) \approx \frac{32}{\pi} \left(1 + \frac{\gamma \Delta_0^2}{\omega_0^2} \right) \frac{k^3 v_F^3}{\omega_0^2} e^{-2kaly}. \quad (15)$$

Expressions (14) and (15) represent our starting point for the discussion that follows.

III. THEORETICAL RESULTS

In NDGS polymers, doped or injected charges can lead to the formation of either polarons or bipolarons, depending on the formation energy of the excitations and the relative energy difference between the two configurations upon doping. Here we apply the solutions to the BK model to predict the effect of the doping concentration on the electronic excitations in P3HT. We considered three types of band diagrams as shown in Fig. 2. They correspond to (a) a first-order transition between a bipolaron and a polaron lattice, (b) a gap closure of the polaron band and the conduction or the valence band, and (c) a gap closure between the bipolaron band and the conduction or the valence band. In the latter two cases, we look for the condition that the polaron (bipolaron) bands merge with the extended states and we expect these transitions to be of second order.

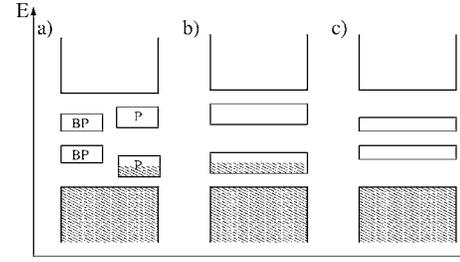


FIG. 2. Schematic diagram of the localized gap states in a P3HT polymer with p -type doping showing three scenarios for the metal-insulator transition including: (a) the crossover between the bipolaron and the polaron formation energy (the lower polaron band is partially filled) upon doping; (b) the polaron bands broaden to merge with the continuum; (c) the bipolaron band broaden to merge with the continuum. The shades are indicative of occupied electronic bands.

A. Optical-absorption energies

Before proceeding to calculate the critical doping concentration that can give rise to metallic states, we calculate the localized energy levels and the formation energy for the polarons and bipolarons of P3HT polymers. The two excitation states correspond to a pair of symmetrically localized levels⁴⁸ in the gap that can be calculated from Eq. (5). To solve for k , we apply the self-consistency condition Eq. (6),

$$\frac{\gamma z_p}{\sqrt{1 - z_p^2}} = \sin^{-1} \sqrt{1 - z_p^2} - \frac{\pi}{4} \quad (16)$$

and

$$\frac{\gamma z_b}{\sqrt{1 - z_b^2}} = \sin^{-1} \sqrt{1 - z_b^2}, \quad (17)$$

for the polaron and the bipolaron configuration, respectively, where $z = k\xi_0$. The confinement parameter γ can be either estimated from the energy splitting between the doping-induced gap states²⁸ or by solving for the phonon propagator from Raman resonance dispersion data.³¹ In either method, γ is estimated to be 0.3–0.4 in P3HT (we discuss later the effect of disorder on this parameter).¹⁹ Solving the above two equations, we find that z_p is in the range 0.553–0.517 and z_b in the range 0.867–0.829.

The energy gap of P3HT has been determined to be $2\Delta_0 = 2.1$ eV.¹⁹ Together with the above values of z , we find the localized energy levels ω_0 that correspond to the polaron and the bipolaron. The singly occupied polaron states allow three optical-absorption transitions, namely, a transition between the valence band and the $-\omega_0$ level (Ω_1), a transition between the valence band and the $+\omega_0$ level (Ω_2), and a transition between the two localized levels (Ω_3).²⁸ For the bipolarons instead, the last type of transition between the two localized levels is forbidden because the localized states are either both empty or doubly occupied. Using the value of $\gamma = 0.4$ in P3HT, we calculated the optical transition frequencies corresponding to the three transitions for the polaron and the two allowed transitions for the bipolarons in Table I.

TABLE I. The eigenvalues, the subgap optical transition energies, and the formation energies of a polaron and a bipolaron in P3HT calculated from the BK model. The values in the parentheses are calculated using $\gamma=0.3$. The units are eV.

Excitations	ω_0	Ω_1	Ω_2	Ω_3	E
Polaron	0.89 (0.87)	0.16	1.94	1.78	1.0
Bipolaron	0.59 (0.52)	0.46	1.74		1.64

Substituting the self-consistent condition into Eq. (7), we also find that the formation energy of a polaron and a bipolaron can be expressed as $E_{p,d} = \frac{4}{\pi} \Delta_0 N(z)$ with $N(z) = z + \gamma \tanh^{-1}(z)$ and their values are shown in Table I.

B. Transition between bipolarons and polarons

We here discuss the transition between the bipolaron lattice and the polaron lattice [see Fig. 2(a)]. This first-order phase transition in NDGS conjugated polymers has been previously proposed without, however, an explicit calculation of the critical doping density.^{30,32} This transition is similar to the energy crossover between the soliton lattice and the metallic polaron lattice, as proposed for *trans*-PA by Kivelson and Heeger.³⁰ The formation energy of a bipolaron is smaller than the formation energy of two single polarons, as also verified by the formation energies that we have calculated in the preceding subsection. Therefore upon doping, the charges will be stored in bipolarons rather than the polarons. However, due to the partial filling, the energy per polaron changes with doping, whereas the bipolaron energies remain unchanged because the bipolaron bands are either doubly occupied or empty. The condition to be satisfied by this transition is

$$W_p(y) = \pi(2E_p - E_b), \quad (18)$$

where $W_p(y)$ is the bandwidth of the polarons we have derived in Sec. II. Substituting the formation energy of a polaron and a bipolaron in the above equation, we get

$$W_p(y) = 4\Delta_0[2N(z_p) - N(z_b)]. \quad (19)$$

Using the polaron bandwidth, Eq. (14), we can solve for the critical dopant concentration

$$y_c = -\frac{z_p a}{\xi_0} \left\{ \ln \frac{\sqrt{1-z_p^2}[2N(z_p) - N(z_b)]}{2z_p^2} \right\}^{-1}, \quad (20)$$

where ξ_0 is the characteristic length that can be determined from $\xi_0 \approx \frac{W}{2\Delta_0} a$,³⁰ with a the lattice spacing and W the π bandwidth. Since the π bandwidth is a rather universal constant for most of conjugated polymers, we have taken a typical value $W \sim 10$ eV,³³ and obtained $\xi_0 \approx 4.7a$. Therefore we find that $y_c \sim 0.092$.

C. Polaron gap closure

A second possible scenario corresponds to the case in which the polaron energy levels stay unchanged upon doping but the bandwidth of the polaron states broadens [see Fig. 2(b)]. When the doping is sufficiently large, the polaron band

can merge with the extended states. This situation can be realized as long as the condition

$$W_p(y) = 2\Omega_1 \quad (21)$$

is satisfied. Substituting this in the expression for the polaron bandwidth we obtain

$$\frac{8z_p^2 \Delta_0}{\sqrt{1-z_p^2}} e^{-kaly} = 2\Omega_1 \quad (22)$$

and thus

$$y_c = -\frac{z_p a}{\xi_0} \left(\ln \frac{\Omega_1 \sqrt{1-z_p^2}}{4\Delta_0 z_p^2} \right)^{-1}. \quad (23)$$

Using the lowest absorption energy of a polaron state found in Sec. III A, i.e., $\Omega_1 = 0.16$ eV, we find that the critical doping concentration is $y_c = 0.051$.

D. Bipolaron gap closure

Similar to the case of the polaron, merging between the bipolaron band and the valence band [see Fig. 2(c)] can also occur if the condition

$$W_b(y) = 2\Omega_1 \quad (24)$$

is satisfied. From the bipolaron bandwidth Eq. (15), the above condition becomes

$$\frac{32}{\pi} \frac{\Delta_0 z_b^3}{1-z_b^2} \left(1 + \frac{\gamma}{1-z_b^2} \right) e^{-2kaly} = 2\Omega_1, \quad (25)$$

hence

$$y_c = -\frac{2z_b a}{\xi_0} \left\{ \ln \frac{\pi \Omega_1 (1-z_b^2)^2}{16 \Delta_0 z_b^3 (1-z_b^2 + \gamma)} \right\}^{-1}. \quad (26)$$

Using the result $\Omega_1 = 0.46$ eV and the value of z_b for a bipolaron in Sec. III A, we find that the critical dopant concentration for this transition is $y_c = 0.091$.

IV. INFRARED SPECTROSCOPIC RESULTS

In order to study the insulator-metal transition in conjugated polymers in functional organic FET devices, we carried out systematic investigations of P3HT based FETs employing infrared (IR) spectroscopy. The critical advantage of IR spectroscopy is that it directly probes the electronic excitations associated with the injected carriers in organic FET devices.³⁴ Combined with theoretical analysis in Sec. III, these experiments uncover the nature of the electronic exci-

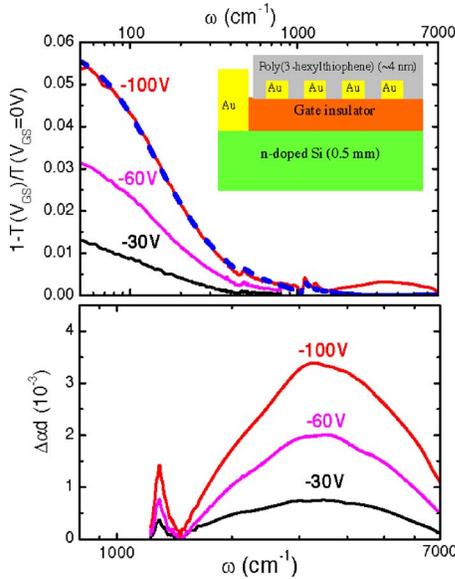


FIG. 3. (Color online) Top panel: the $1-T(V_{GS})/T(V_{GS}=0V)$ spectra for a representative SiO_2 based organic FET device under applied gate voltages V_{GS} . Solid curves: experimental spectra at several gate voltages V_{GS} . Blue dashed curve: the spectrum at -100 V obtained from fitting the low-energy absorption of the accumulation layer in n -Si using the DL model as described in the text. Top inset: a schematic of the cross section of the FET devices. Bottom panel: The mid-IR voltage-induced absorption spectra Δad for the P3HT layer, which are obtained by subtracting absorption due to the accumulation layer in n -Si from the absorption spectra of the device as detailed in the text.

tations in P3HT. Moreover, the carrier density in the accumulation layer of P3HT can be evaluated from the analysis of IR spectroscopic data, which provides interesting insights into the insulator-metal transition in polymers.

Large area organic FET devices^{34,35} (>1 cm^2) with gate insulator deposited on n -Si were investigated in this work. In these devices, source and drain Au electrodes (with a spacing of 50 – 200 μm) were patterned on a 200 -nm-thick SiO_2 gate insulator followed by the deposition of a 4 – 6 -nm-thick P3HT film. The inset of Fig. 3 displays a schematic of the cross section of the device. These devices has transport mobility of about 0.18 cm^2 V^{-1} s^{-1} and breakdown voltage in excess of -100 V.³⁶ In these bottom-contact FET devices, an applied gate voltage induces an accumulation layer^{2,37} in P3HT as well as in n -Si. The former accumulation layer constitutes the p -type conducting channel between the Au electrodes. This channel is not obscured by any other interfaces and is therefore well suited for the spectroscopic studies of the accumulation layer in the polymer film from far-IR to near-IR with the latter cutoff imposed by the band gap of the Si substrate.³⁴ We studied changes of transmission as a function of applied gate voltage V_{GS} normalized by the transmission at $V_{GS}=0$: $T(\omega, V_{GS})/T(\omega, V_{GS}=0)$. Note that in the same sample structure without a P3HT layer, we did not observe any gate voltage induced changes in the IR spectrum. This suggests that no accumulation layer forms in the region between the gold grid electrodes without the P3HT layer on the top of the insulator. The source and drain voltage

is zero in most measurements. All the data reported here were recorded at room temperature with a spectral resolution of 4 cm^{-1} .

We start by analyzing the absorption spectra $\Delta ad=1-T(V_{GS})/T(0V)$ of the organic FET devices displayed in Fig. 3. Here $\Delta\alpha$ is the change of the absorption coefficient of P3HT and d is the thickness of the accumulation layer where absorption is formed. These spectra show several voltage-induced features: (i) a strong absorption in far-IR frequencies ($\omega < 500$ cm^{-1}), (ii) sharp resonances in the 1000 – 1500 - cm^{-1} region, and (iii) a broad band centered around 3500 cm^{-1} . A gradual development of these features with increasing gate voltages V_{GS} suggests that (i)–(iii) are intimately related to the formation of charge accumulation layers on both sides of the oxide. Features (ii) and (iii) are spectroscopic signatures of electrostatically doped carriers in P3HT.³⁴ Sharp resonances in the 1000 – 1500 - cm^{-1} range result from the IR active vibrational modes (IRAVs);¹⁸ i.e., Raman modes made IR active by distortions of the polymer backbone caused by the self-localized charges. The broad absorption band centered around 3500 cm^{-1} is usually ascribed to polaron or bipolaron states positioned in the gap;¹⁸ the line shape of the broad band does not allow one to discriminate between the two types of excitations. Both the IRAV modes and the polaron band can be quantitatively described³⁴ by the amplitude mode model³⁸ of charge excitations in conjugated polymers. Optical conductivity due to polarons in adiabatic/nonadiabatic regimes has been considered by Fratini and Ciuchi.³⁹ Features (ii) or (iii) are significantly weaker than the far-IR absorption (i). We attribute the latter to the charge accumulation layer on the n -Si side of the gate dielectric. The validity of this assignment is supported by quantitative agreement of the far-IR data with results for heavily doped Si,⁴⁰ as will be described in detail below.

We now turn to the analysis of the accumulation layer (AL) in n -Si. These results will help us to quantify the two-dimensional (2D) carrier density which is the same on both sides of the gate dielectric in the P3HT–insulator– n -Si structure. This task can be accomplished, for example, by fitting the low-energy absorption with the Drude-Lorentz (DL) model, in which the complex dielectric function $\epsilon(\omega)$ has the form

$$\epsilon(\omega) = -\frac{\omega_{pD}^2}{\omega^2 + i\Gamma_D\omega} + \frac{\omega_p^2}{\omega_0^2 - \omega^2 - i\Gamma\omega} + \epsilon_\infty. \quad (27)$$

The first term in Eq. (27) stands for the Drude free carrier response with the relaxation rate Γ_D and the plasma frequency ω_{pD} given by $\omega_{pD}^2 = \frac{4\pi N_f e^2}{m_b}$, where N_f is the 2D density of free carriers and $m_b = 0.26m_e$ is the conduction-band mass of Si. The second term is used to account for small deviations of the dielectric function in mid-IR from the Drude form. The last term ϵ_∞ is the high-frequency dielectric constant. Two scenarios are the most likely origins of the second term: frequency dependence of the relaxation rate of free carriers and/or interband transitions from donor impurities to the conduction band of Si at ω_0 .⁴⁹ The interband transitions are characterized by the relaxation rate Γ and the plasma frequency ω_p given by $\omega_p^2 = \frac{4\pi N_M e^2}{m^*}$, where N_M is the

TABLE II. The parameters of the Drude-Lorentz fitting [Eq. (27)] of the absorption of the accumulation layer in *n*-Si of the FET device at $V_{GS} = -100$ V. We use the “effective 2D” oscillator strengths ω_{pD}^2 and ω_p^2 associated with 2D carrier densities N_f and N_M , respectively.

ω_{pD}^2	2.57 cm^{-1}	N_M	$0.28 \times 10^{13} \text{ cm}^{-2}$
N_f	$0.74 \times 10^{13} \text{ cm}^{-2}$	Γ	1400 cm^{-1}
Γ_D	132 cm^{-1}	ω_0	360 cm^{-1}
ω_p^2	0.96 cm^{-1}	ε_∞	10

2D charge density and $m^* \sim m_b$ is the renormalized mass. It is advantageous to carry out the analysis using the “effective 2D” carrier density in Eq. (27) in order to avoid any assumptions about the thickness of the accumulation layer in *n*-Si. The total 2D carrier density $N_{2D} = N_f + N_M$ represents a lower limit of the density of the voltage-induced charges.

In order to evaluate the consistency of the DL model with the data, we first obtained optical constants for each of the constituting layers of our devices as described in Ref. 35 and then considered the transmission of the multilayered sample: P3HT/SiO₂/2D-AL/*n*-Si. Results shown in the top panel of Fig. 3 suggest that the experimental spectra can be adequately described by modeling the AL response using Eq. (27) with parameters presented in Table II. Here we assumed that voltage induced changes of P3HT in far-IR are negligible small in accord with dc measurements.³⁶ The parameters we obtained for the response of AL are in good agreement with the optical spectra of metallic phosphorus doped Si.⁴⁰ The voltage-induced absorption spectra in the mid-IR frequencies for the P3HT layer can be obtained by subtracting the absorption due to the accumulation layer in *n*-Si from the absorption spectra of the device, which are displayed in the bottom panel of Fig. 3.

In Fig. 4 we plot the 2D carrier density of charges N_{2D} injected in P3HT polymers obtained from the previous analysis as a function of the gate voltage V_{GS} . The carrier densities in the polymers reaches 10^{13} cm^{-2} at the highest voltage. Therefore we have shown that the carrier density in

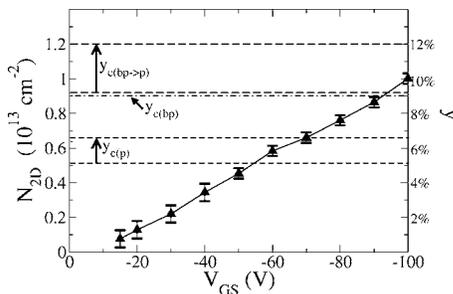


FIG. 4. The 2D carrier density of charges and the corresponding doping level y (solid triangles, solid line is to guide the eye) induced in the P3HT polymer as a function of the gate voltage determined as described in the text. The density reaches 10^{13} cm^{-2} (equivalent to 10%) at the highest V_{GS} applied. The horizontal lines mark the different ranges of the critical dopant concentration at which metallic states can be expected predicted from the theoretical models in Secs. III B and III D.

P3HT in our organic FETs at the highest gate biases is about $N_{3D} \sim 10^{20} \text{ cm}^{-3}$ corresponding to approximately one charge in every ten thiophene rings, i.e., $y \cong 10\%$.

V. DISCUSSION

A. Comparison with the IR spectra

Let us now compare the theoretical predictions with the IR spectroscopic results and discuss their implications. In Sec. III A, we have estimated the lowest optical-absorption frequency to be 0.16 eV for polarons and 0.46 eV for bipolarons. In our IR spectroscopic studies, the localized absorption band due to charge injection is found at about 0.45 eV. The frequency is appreciably higher than the predicted polaron absorption, while it matches reasonably well with the predicted bipolaron absorption. The result seems to suggest that the localized band is due to bipolaron excitations. On the other hand, polaronic energies reported in previous work seem to vary appreciably suggesting a dependence on the sample qualities and experimental platforms. Indeed, very broad range of polaron energies ranging from 0.06 to 0.35 eV has been reported in different P3HT systems.^{9,41,42} Considering that the simple model followed in this paper assumes idealized 1D infinite chains, there is a need to discuss in some detail the disorder effect on the localized bands and the optical transition energies. This discussion is presented in the subsequent subsection.

The calculations in Sec. III show that a relatively low doping concentration of about 5% is expected to close the gap between the polaron bands and the continuum states, leading to a possible second-order transition in P3HT. In our actual experiments, with a gate voltage of -100 V applied, the charge injection of the P3HT polymers achieves a doping concentration as high as 10% (see Fig. 4), exceeding the threshold over which the polaron-related transition occurs. However, we do not have any direct evidence of metallic states, for example, through reduction of the oscillator strength of the IRAV modes near this doping range.⁴³ The insulating state at the doping level of 5% is thus consistent with our bipolaron interpretation of the spectra.

On the other hand, our results indicate that metallic states in P3HT can be expected at a doping concentration of about 10% due to either a first-order transition to the metallic polaron lattice or a possible second-order transition by closing the gap between the bipolaron band and the valence band. Both thresholds are close to the highest doping achieved in our charge-injected polymers. In the following we suggest two issues that can lead to the absence of direct evidence of metallic signatures in the present experiment.

First, recent experiments in P3HT FET suggested that at low temperature, a dc field is needed in order to overcome the tunneling barriers between the occupied localized states which can suppress conductivity of polymers and result in insulating properties.¹⁷ Therefore while it is possible that the present P3HT system might have achieved a metallic carrier density, it is not clear that one can observe metallic conductivity, as found recently that only a small fraction of the field-induced charge contributes to metallic conduction while most charges occupying the localized states.¹⁷ Second,

in the FET device of interest here, the absorption in the accumulation layer on the n -Si side of the gate dielectric dominates the observed spectrum in the far-IR frequencies, because of its much higher mobility compared to that of P3HT. As a result, it is difficult to directly subtract the Drude absorption due to the n -Si from the absorption of the device so that the Drude absorption and thus the metallic signatures of the polymer at the far-IR frequency can be extracted.

B. Effect of disorder

In quasi-1D conducting polymers, disorder is expected to have a particularly important role affecting both transport and other phenomena compared to systems with higher dimensions. Indeed, previous work has suggested that insulator-metallic transitions in *trans*-PA can result from disorder in the polymers.⁴⁴ Here we discuss the sensitivity of our predictions to disorder of the polymers in terms of the confinement parameter $\gamma = \frac{\Delta_e}{\lambda\Delta_0}$, which is directly related to the energies of the localized states.

In the presence of a higher degree of disorder, we expect that the degree of the conformational nondegeneracy would be lowered due to the configurational randomness. Hence the external gap parameter Δ_e is lower compared to that of more regio-regular polymers. More importantly, disorder affects the confinement parameters through the electron-phonon couplings, the strength strongly influences the electronic structure of organic polymers.⁴⁵ In organic semiconductors, the electron-phonon coupling constant is related to the conformational disorder through the degree of the chain conjugation. The coupling decreases with the conjugation length,⁴⁶ i.e., the length of the polymer segments separated by defects. Hence the electron-phonon coupling increases with disorder in the conjugated polymers. On the basis of these arguments, one can anticipate that in the presence of disorder, the confinement parameters γ would be smaller than that in polymers with higher regio-regularity.

In Secs. III B and III D, we have carried out calculations of the critical densities in P3HT using $\gamma \cong 0.4$. Given the trend that γ decreases with increasing disorder, it is instructive to recalculate the results at values of $0 < \gamma < 0.4$. To this end, we have recalculated the values using $\gamma = 0.01$ and obtained $\omega_0 \cong 0.75$ eV and $\omega_0 \cong 0.1$ eV that correspond to the lowest optical-absorption energies of 0.3 and 0.95 eV for the polarons and bipolarons, respectively. Note that the two bipolarons bands merge into a single mid-gap state at $\gamma \cong 0$. The results show that both the polaron and the bipolaron absorptions blueshift with increasing disorder of the polymers. However, even at the smallest value of γ , it appears that the localized absorption in our experiment is still considerably higher compared to the predicted polaron absorption, thus supporting our assignment of the localized band as due to bipolarons, rather than polarons.

Extending this analysis to the larger end of γ , on the other hand, we find the lowest polaron absorption energies reduced significantly to less than 0.1 eV when $\gamma \cong 1$. This value is consistent with the recent photoinduced absorption measurement by Österbacka *et al.* of highly regio-regular P3HT polymers,⁴¹ where the polaron absorptions are found to su-

perpose with the IRAV modes at very low frequencies less than 0.1 eV. Similar absorption features were also revealed by Brown *et al.* using charge modulation spectroscopy in P3HT based metal-oxide semiconductor (MOS) diode, albeit assignment of the polaron absorptions were given somewhat differently.²¹ It is important to note that a distinction exists between the RR P3HT in our experiment and those in the earlier work,^{21,41} despite both exhibit high mobilities. In our experiment, the charge accumulation layer is restricted to the polymer-gate dielectric interface within 1–2 nm of the 4–6-nm-thick P3HT films due to the bottom contact FET structure, the interfacial disorder¹⁵ would play a much more important role than in the “bulk” form of P3HT in the earlier experiments. We thus suggest that the difference between the absorption peak we observed and those from the earlier work might be related to the extent of the interfacial disorder present in the samples.

We have also recalculated the doping thresholds at $0 < \gamma < 0.4$. This leads to a range of the critical doping values as shown in Fig. 4. For the first two cases discussed in Secs. III B and III C, the thresholds increase slightly with decreasing γ , i.e., with increasing disorder. For the bipolaron gap closure discussed in Sec. III D, the value of γ is lower bounded by the value at which the two bipolaron bands in the gap touch due to the band broadening, which corresponds to $\gamma \cong 0.3$. In other words, below this value, the bipolaron gap closure condition cannot be satisfied. In the range of $0.3 < \gamma < 0.4$, the critical doping concentration is nearly unchanged. We have indicated the latter threshold by a single line in Fig. 4. Given the fact that these ranges appear relatively insensitive to the structural disorder described by γ , together with the assignment of the carries to bipolarons, we may conclude that the maximum carried densities achieved in the present experiments are in close proximity to the regime where a first-order transition from bipolaron lattice to metallic polaron lattice occurs.

We conclude this section by stressing that due to contact and interface effects, we expect the precise value of the critical density for insulator-metal transition to be larger than the one we have predicted above. In this respect, we compare our results to very recent experimental data obtained by Panzer *et al.*¹⁶ and Dhoot *et al.*²⁵ The first authors have reported field-induced charge injection as high as 10^{22} cm⁻³ in P3HT FETs with polyelectrolyte gate dielectric. At such densities—higher than our predicted minimal density—P3HT indeed shows metallic transport properties. The second group²⁵ finds strong evidence of metallic behavior in a polymer which is structurally very similar to P3HT. This metallic behavior is again observed at carrier densities larger than the ones we predict. These results therefore corroborate our prediction that a critical carrier density exists beyond which metal-insulator transition can be expected in P3HT.

C. Limitation of the model

We briefly comment on the limitations of our theoretical analysis. The BK model used in this paper does not directly account for the electron-electron interactions. In spite of ongoing efforts to incorporate electron-electron interactions in

the models of conjugated polymers,⁴⁷ it is currently far from clear how that has to be done. Nonetheless, it is worth noting that to some extent, electron-electron interactions are effectively included in our calculations through the use of experimental values for the parameters such as the band gap, the characteristic correlation length, and the confinement parameters. We expect that explicit inclusion of the interactions in the present treatment may modify somewhat the critical concentrations predicted in the analysis. On the other hand, the theoretically calculated polaron and bipolaron energies and the experimental values obtained from our P3HT FET are in reasonable agreement. This agreement and the insensitivity of the results to the doping concentration, and hence to the strength of the electron-electron interactions suggest that the electron-lattice interactions are still the dominating effect in P3HT polymers. The electron-phonon coupling model we use thus captures the essential physics of localized excitations.

The BK model also does not account for the electric field. While the effect of the electric field is important for understanding polaron dynamics, we expect that it does not play an important role in regioregular P3HT-based devices considered in this paper. In the P3HT structures we have studied, the P3HT chains form lamellae normal to the substrate with the chains oriented parallel to the substrate surface.⁹ As the applied gate field is perpendicular to the film surface, we expect that the P3HT chains are not subject to the gate field

in the parallel direction and thus the electrostatic potential along each chain is constant.

VI. CONCLUSION

In this paper, we have analyzed the conditions to obtain metallic behavior in charge-injected P3HT polymers through a first-order phase transition between bipolaron and polaron lattices or gap closure between the bipolar and polaron bands and the continuum bands. IR spectroscopic measurements in P3HT thin film FET show that the highest charge injection level achieved in the present experiments is in proximity to the predicted doping thresholds for the first case, indicating that metallic behavior can be anticipated. Optical-absorption frequencies are predicted for both polarons and bipolarons. The frequencies associated to bipolarons are in good agreement with the absorption peak observed. Both conclusions remain true even when disorder is taken into account. We therefore conclude that the localized excitations we observe are likely to be due to bipolarons and a first-order transition from the bipolaron lattice to the polaron lattice can be expected.

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- ⁴⁸For P3HT, the two localized levels are not exactly symmetric due to the sulfur atom that breaks the electron-hole symmetry, but the difference should be small.
- ⁴⁹This ω_0 should not be confused with the energy level defined in Sec. II A.